

## General Description

The MY130N10P is the high cell density trenched N-ch MOSFETs, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

The MY130N10P meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.



## Features

V <sub>DSS</sub>	100	V
I <sub>D</sub>	147	A
R <sub>DS(ON)</sub> (at V <sub>GS</sub> =10V)	4.7	mΩ
R <sub>DS(ON)</sub> (at V <sub>GS</sub> =8V)	5.1	mΩ



## Application

- Switch Mode Power Supplies
- Power Management in Inverter System
- Battery Management System

## Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
MY130N10P	TO-220	130N10P	1000

## ABSOLUTE RATINGS (T<sub>c</sub>=25 °C)

Parameter	Symbol	Value	Unit
		MY130N 10	
Drain-Source Voltage	V <sub>DS</sub>	100	V
Drain Current -continuous *	I <sub>D</sub> (T <sub>c</sub> =25°C) (Silicon Limited)	147	A
	I <sub>D</sub> (T <sub>c</sub> =25°C) (Package Limited)	120	A
	I <sub>D</sub> (T <sub>c</sub> =100 °C) (Silicon Limited)	93	A
Drain Current – pulsed (note1)	I <sub>DM</sub>	588	A
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Single Pulsed Avalanche Energy (note 2)	E <sub>AS</sub>	288	mJ
Avalanche Current (note 1)	I <sub>AR</sub>	24	A
Repetitive Avalanche Current (note 1)	E <sub>AR</sub>	35	mJ
Peak Diode Recovery dv/dt (note 3)	dv/dt	5.0	V/ns
Power Dissipation	P <sub>D</sub> (T <sub>c</sub> =25 °C)	173.6	W
	-Derate above 25°C	1.39	W/°C
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55+150	°C
Maximum Lead Temperature for Soldering Purposes	T <sub>L</sub>	260	°C

**Electrical Characteristics** at  $T_J=25\text{ }^\circ\text{C}$  unless otherwise specified

项目 Parameter	符号 Symbol	测试条件 Tests conditions	最小 Min	典型 Typ	最大 Max	单位 Units	
<b>关态特性 Off -Characteristics</b>							
漏-源击穿电压 Drain-Source Voltage	$\text{BV}_{DSS}$	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	100	-	-	V	
击穿电压温度特性 Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{DSS}/\Delta T_J$	$I_D=250\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$	-	0.1	-	V/ $^{\circ}\text{C}$	
零栅压下漏极漏电流 Zero Gate Voltage Drain Current	$I_{DS(on)}$	$V_{DS}=100\text{V}, V_{GS}=0\text{V}, T_C=25\text{ }^\circ\text{C}$	-	-	1	$\mu\text{A}$	
		$V_{DS}=80\text{V}, T_C=125\text{ }^\circ\text{C}$	-	-	100	$\mu\text{A}$	
栅极体漏电流 Gate-body leakage current	$I_{GSS} (\text{FIR})$	$V_{GS}=0\text{V}, V_{DS}=\pm 20\text{V}$	-	-	$\pm 100$	nA	
<b>通态特性 On-Characteristics</b>							
阈值电压 Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D=250\mu\text{A}$	2.0	-	4.0	V	
静态导通电阻 Static Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS}=10\text{V}, I_D=50\text{A}$	-	4.7	5.4	$\text{m}\Omega$	
正向跨导 Forward Transconductance	$g_{fs}$	$V_{DS} = 10\text{V}, I_D=50\text{A}$ (note 4)	-	75	-	S	
<b>动态特性 Dynamic Characteristics</b>							
栅电容 Gate Resistance	$R_g$	$f=1.0\text{MHz}, V_{DS} \text{ OPEN}$	-	1.6	-	Ω	
输入电容 Input capacitance	$C_{iss}$		-	5100	-	pF	
输出电容 Output capacitance	$C_{oss}$		-	878	-		
反向传输电容 Reverse transfer capacitance	$C_{rss}$		-	75	-		
<b>开关特性 Switching Characteristics</b>							
延迟时间 Turn-On delay time	$t_{d(on)}$	$V_{DD}=50\text{V}, I_D=50\text{A}, R_C=5\Omega, V_{GS}=10\text{V}$ (note 4, 5)	-	24	-	ns	
上升时间 Turn-On rise time	$t_r$		-	21	-	ns	
延迟时间 Turn-Off delay time	$t_{d(off)}$		-	50	-	ns	
下降时间 Turn-Off Fall time	$t_f$		-	27	-	ns	
栅极电荷总量 Total Gate Charge	$Q_g$	$V_{DS}=50\text{V}, I_D=50\text{A}, V_{GS}=10\text{V}$ (note 4, 5)	-	74	-	nC	
栅-源电荷 Gate-Source charge	$Q_{gs}$		-	25	-	nC	
栅-漏电荷 Gate-Drain charge	$Q_{gd}$		-	14	-	nC	
<b>漏-源二极管特性及最大额定值 Drain-Source Diode Characteristics and Maximum Ratings</b>							
正向最大连续电流 Maximum Continuous Drain-Source Diode Forward Current			$I_S$	-	-	147 A	
正向最大脉冲电流 Maximum Pulsed Drain-Source Diode Forward Current			$I_{SM}$	-	-	588 A	
正向压降 Drain-Source Diode Forward Voltage	$V_{SD}$	$V_{GS}=0\text{V}, I_S=50\text{A}$	-	-	1.2	V	
反向恢复时间 Reverse recovery time	$t_{rr}$	$V_{GS}=0\text{V}, I_S=50\text{A}, dI/dt=100\text{A}/\mu\text{s}$ (note 4)	-	66	-	ns	
反向恢复电荷 Reverse recovery charge	$Q_{rr}$		-	150	-	nC	

**Typical Characteristics**

**热特性 THERMAL CHARACTERISTIC**

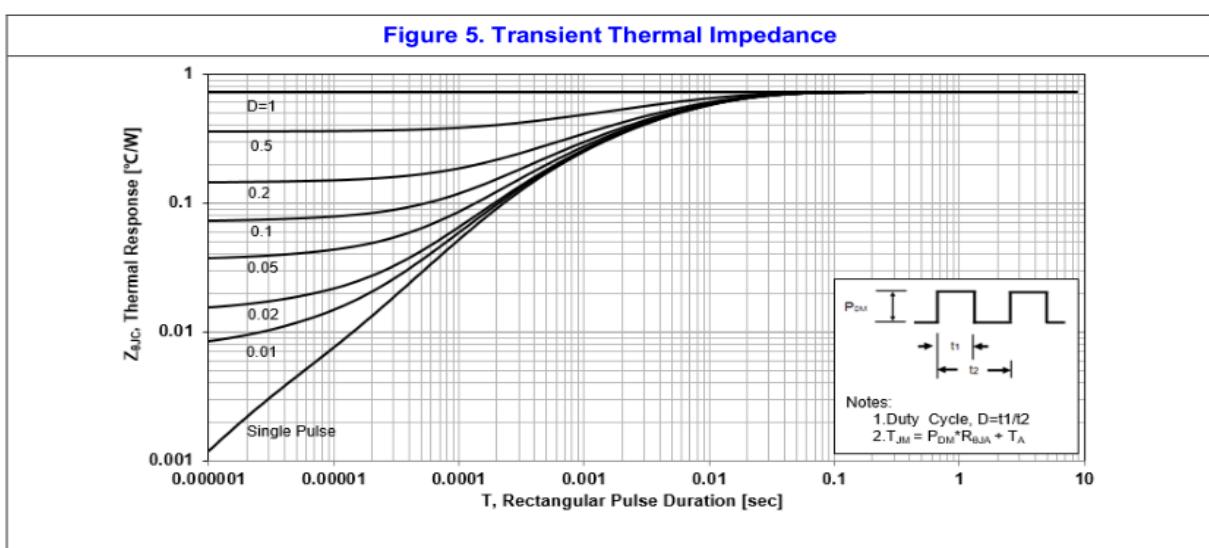
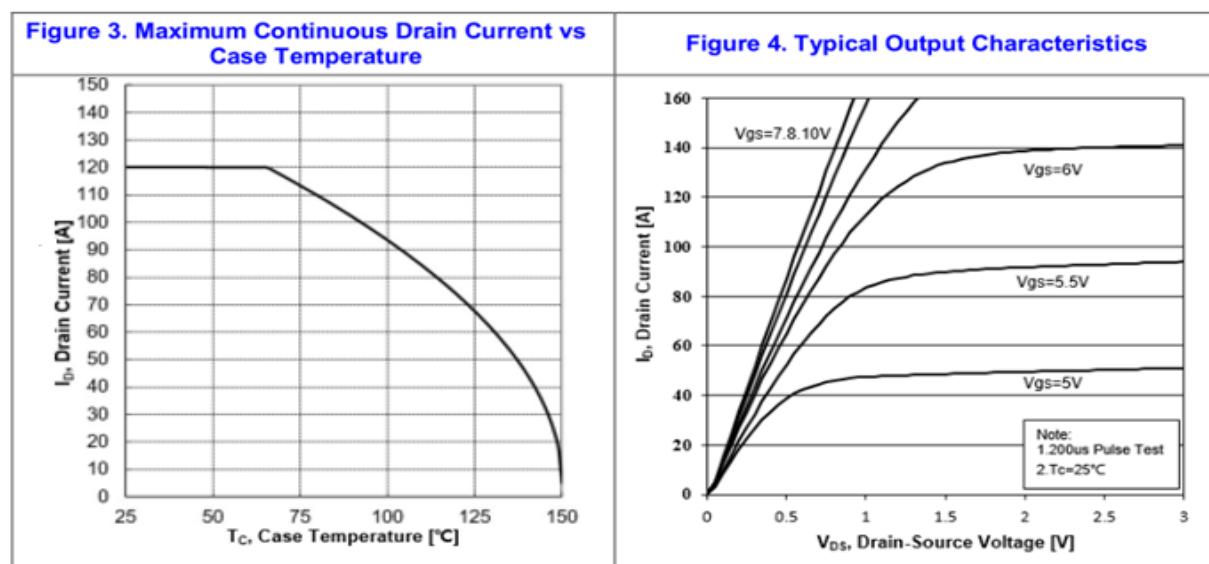
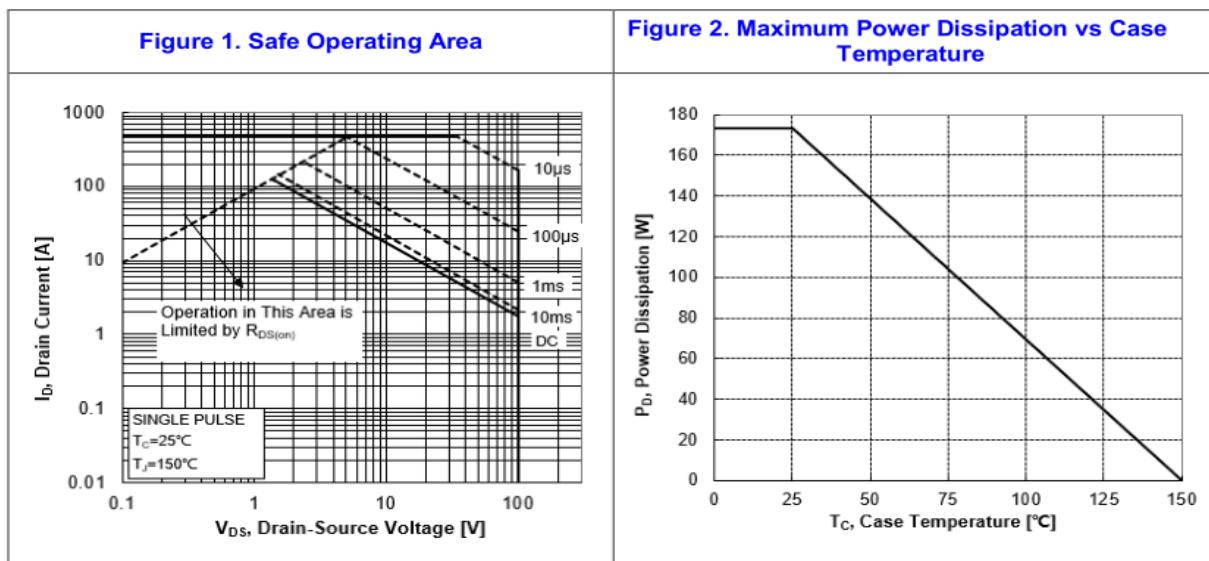
项目 Parameter	符号 Symbol	P/S130N10	单位 Unit
结到管壳的热阻 Thermal Resistance, Junction to Case	R <sub>th(j-c)</sub>	0.72	°C/W
结到环境的热阻 Thermal Resistance, Junction to Ambient	R <sub>th(j-A)</sub>	62.5	°C/W

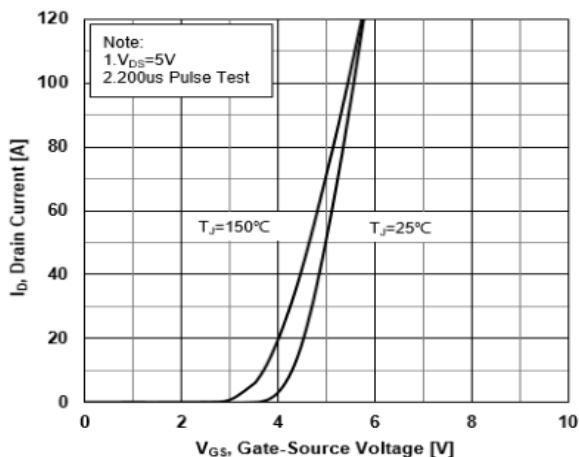
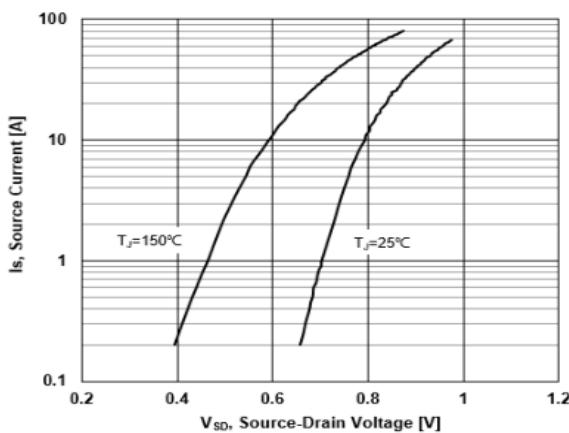
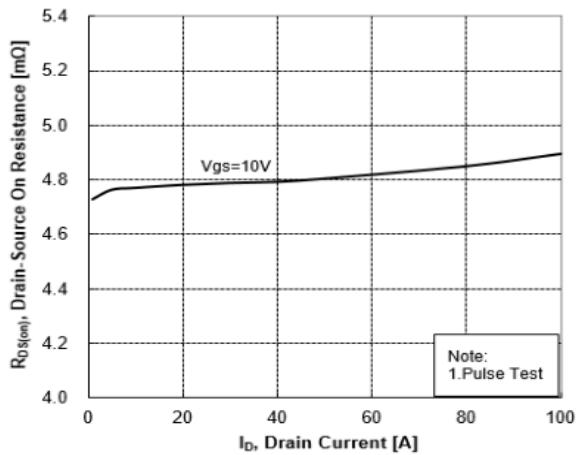
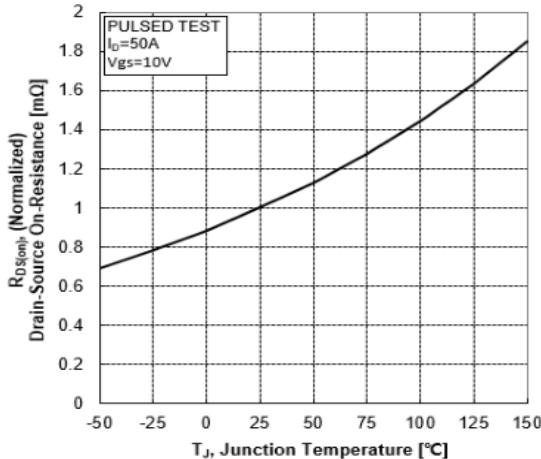
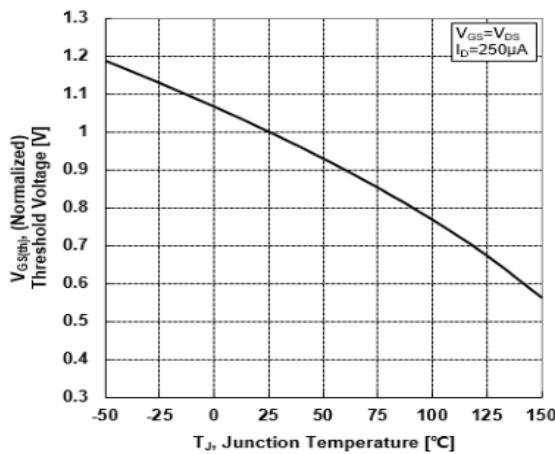
注释:

- 1: 脉冲宽度由最高结温限制
- 2: L=1mH, I<sub>AS</sub>=24A, V<sub>DD</sub>=50V, R<sub>G</sub>=25 Ω, 起始结温 T<sub>J</sub>=25°C
- 3: I<sub>SD</sub> ≤ 147A, di/dt ≤ 300A/μs, V<sub>DD</sub> ≤ BV<sub>DSS</sub>, 起始结温 T<sub>J</sub>=25°C
- 4: 脉冲测试: 脉冲宽度 ≤ 300μs, 占空比 ≤ 2%
- 5: 基本与工作温度无关

Notes:

- 1: Pulse width limited by maximum junction temperature
- 2: L=1mH, I<sub>AS</sub>=24A, V<sub>DD</sub>=50V, R<sub>G</sub>=25 Ω, Starting T<sub>J</sub>=25°C
- 3: I<sub>SD</sub> ≤ 147A, di/dt ≤ 300A/μs, V<sub>DD</sub> ≤ BV<sub>DSS</sub>, Starting T<sub>J</sub>=25°C
- 4: Pulse Test: Pulse Width ≤ 300μs, Duty Cycle≤2%
- 5: Essentially independent of operating temperature



**Figure 6. Typical Transfer Characteristics****Figure 7. Source-Drain Diode Forward Characteristics****Figure 8. Drain-Source On-Resistance vs Drain Current****Figure 9. Normalized On-Resistance vs Junction Temperature****Figure 10. Normalized Threshold Voltage vs Junction Temperature****Figure 11. Normalized Breakdown Voltage vs Junction Temperature**